1. Excess carriers are photo-generated at the y = 0 plane of an infinitely long *n*-type semiconductor sample, placed in a uniform electric field $E = E_0 \hat{y}$, at room temperature. The excess carrier concentration within the semiconducting sample is determined to be

$$\delta p(y) = \Delta p e^{\theta y} \qquad \forall y > 0$$
$$= \Delta p e^{\lambda y} \qquad \forall y < 0$$

(a) Prove that $L_p^2 = -\theta \lambda$ (*Here*, L_p is the hole diffusion length)

(b) Plot $\delta p(y)$ versus y

2. At T = 0, the Fermi level of a *n*-type semiconductor, with a direct bandgap of 1 eV, lies 984 meV above the valence band, whereas at T = 100 K, the intrinsic Fermi level of the same semiconductor lies 6.5 meV below the midgap. If the relative dielectric constant of the semiconductor is $\kappa = 11$, what is the exciton binding energy in the semiconductor?

(5)

(5+3=8)

3. If the Hall coefficient due to light holes is $R_H^{lh} = \frac{E_y}{j_x^{lh}B}$ and the Hall coefficient due to heavy holes is $R_H^{hh} = \frac{E_y}{j_x^{lh}B}$, then show that the Hall coefficient of the p-type semiconductor, at the limit of $\mu_p^{(lh,hh)}B \ll 1$ can be written as

$$R_{H} = \frac{E_{y}}{j_{x}B} = \underbrace{\frac{1}{|e|}}_{\sigma_{hh}} \frac{\sigma_{hh}^{2} R_{H}^{hh} + \sigma_{lh}^{2} R_{H}^{lh}}{(\sigma_{hh} + \sigma_{lh})^{2}} .$$
(7)

4. An indirect band gap semiconductor having the minima along the (100) directions, and within the 1st Brillouin zone, has a bandgap of 0.77 eV, room temperature electron mobility of 600 cm²/V-s, and momentum relaxation time of 86 *fs*. The constant energy surface in the conduction band, along the [100] direction, is represented by

$$\varepsilon(k) = \frac{\hbar^2}{2m^*} (k_x - k_{x0})^2 + \frac{\hbar^2}{4m^*} (k_y^2 + k_z^2)$$

What is the intrinsic carrier concentration of the semiconductor at room temperature, if the heavy hole and the light hole masses are given by $m_{hh}^* = 0.48m_0$ and $m_{lh}^* = 0.16m_0$?

(5)

5. A semiconductor, with a direct bandgap of 1.1 eV, has electron and hole effective masses of $m_e^* = 0.4m_0$ and $m_h^* = 0.7m_0$, respectively. This semiconductor is doped *n*-type such that the dopants are fully ionized at room temperature, for a doping density of $N_D = 2 \times 10^{17}$ cm⁻³. Low level photoexcitation (at room temperature) of this *n*-type semiconductor creates excess carriers, such that at steady state, the quasi fermi levels are separated by 420 meV. If the hole lifetime is $\tau_p = 2 \,\mu s$, estimate the optical generation rate.

(5)